

# IRFP4410ZPbF

HEXFET® Power MOSFET

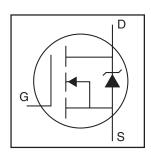
### **Applications**

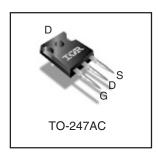
- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

| $V_{DSS}$                        | 100V          |
|----------------------------------|---------------|
| R <sub>DS(on)</sub> typ.         | $7.2 m\Omega$ |
| max.                             | $9.0 m\Omega$ |
| I <sub>D</sub> (Silicon Limited) | 97A           |

### **Benefits**

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free





| G    | D     | S      |
|------|-------|--------|
| Gate | Drain | Source |

### **Absolute Maximum Ratings**

| Symbol                                  | Parameter   | Max.             | Units |
|---|---|------------------|-------|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) | 97               |       |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, VGS @ 10V (Silicon Limited)             | 69               | Α     |
| I <sub>DM</sub>                         | Pulsed Drain Current ①  | 390              |       |
| P <sub>D</sub> @T <sub>C</sub> = 25°C   | Maximum Power Dissipation   | 230              | W     |
|   | Linear Derating Factor  | 1.5              | W/°C  |
| $V_{GS}$                                | Gate-to-Source Voltage  | ± 20             | V     |
| dv/dt                                   | Peak Diode Recovery ③   | 16               | V/ns  |
| T <sub>J</sub>                          | Operating Junction and  | -55 to + 175     | °C    |
| T <sub>STG</sub>                        | Storage Temperature Range   |                  |       |
|   | Soldering Temperature, for 10 seconds                             | 300              |       |
|   | (1.6mm from case)   |                  |       |
|   | Mounting torque, 6-32 or M3 screw                                 | 10lb·in (1.1N·m) |       |

### **Avalanche Characteristics**

| E <sub>AS (Thermally limited)</sub> | Single Pulse Avalanche Energy ② | 242                        | mJ |
|-------------------------------------|---------------------------------|----------------------------|----|
| I <sub>AR</sub>                     | Avalanche Current ①             | See Fig. 14, 15, 22a, 22b, | Α  |
| E <sub>AR</sub>                     | Repetitive Avalanche Energy ④   |                            | mJ |

### **Thermal Resistance**

| Symbol       | Parameter                          | Тур. | Max. | Units |
|--------------|------------------------------------|------|------|-------|
| $R_{\pi JC}$ | Junction-to-Case ®                 |      | 0.65 |       |
| $R_{\pi CS}$ | Case-to-Sink, Flat Greased Surface | 0.24 |      | °C/W  |
| $R_{\pi JA}$ | Junction-to-Ambient ®              |      | 40   |       |

### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

| Symbol                          | Parameter                            | Min. | Тур. | Max. | Units | Conditions  |
|---------------------------------|--------------------------------------|------|------|------|-------|---|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 100  |      |      | V     | $V_{GS} = 0V, I_{D} = 250\mu A$                   |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  |      | 0.12 |      | V/°C  | Reference to 25°C, I <sub>D</sub> = 5mA①          |
| R <sub>DS(on)</sub>             | Static Drain-to-Source On-Resistance |      | 7.2  | 9.0  | mΩ    | $V_{GS} = 10V, I_D = 58A $ ④                      |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  |      | 4.0  | V     | $V_{DS} = V_{GS}$ , $I_D = 150\mu A$              |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      |      |      | 20   | μΑ    | $V_{DS} = 100V, V_{GS} = 0V$                      |
|                                 |                                      |      |      | 250  |       | $V_{DS} = 80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       |      |      | 100  | nΑ    | $V_{GS} = 20V$                                    |
|                                 | Gate-to-Source Reverse Leakage       |      |      | -100 |       | $V_{GS} = -20V$                                   |
| $R_G$                           | Internal Gate Resistance             |      | 0.70 |      | Ω     |   |

### Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

| Symbol                     | Parameter   | Min. | Тур. | Max. | Units | Conditions   |
|----------------------------|---|------|------|------|-------|--|
| gfs                        | Forward Transconductance                                    | 140  |      |      | S     | $V_{DS} = 10V, I_D = 58A$                            |
| $Q_g$                      | Total Gate Charge   |      | 83   | 120  | nC    | $I_D = 58A$  |
| $Q_{gs}$                   | Gate-to-Source Charge                                       |      | 19   |      |       | $V_{DS} = 50V$                                       |
| $Q_{gd}$                   | Gate-to-Drain ("Miller") Charge                             |      | 27   |      |       | V <sub>GS</sub> = 10V ⊕                              |
| Q <sub>sync</sub>          | Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> ) |      | 56   |      |       | $I_D = 58A, V_{DS} = 0V, V_{GS} = 10V $ ④            |
| t <sub>d(on)</sub>         | Turn-On Delay Time  |      | 16   |      | ns    | $V_{DD} = 65V$                                       |
| t <sub>r</sub>             | Rise Time   | _    | 52   |      |       | $I_D = 58A$  |
| t <sub>d(off)</sub>        | Turn-Off Delay Time   |      | 43   |      |       | $R_G = 2.7\Omega$                                    |
| t <sub>f</sub>             | Fall Time   |      | 57   |      |       | V <sub>GS</sub> = 10V ④                              |
| C <sub>iss</sub>           | Input Capacitance   |      | 4820 |      | pF    | $V_{GS} = 0V$  |
| C <sub>oss</sub>           | Output Capacitance  |      | 340  |      |       | $V_{DS} = 50V$                                       |
| C <sub>rss</sub>           | Reverse Transfer Capacitance                                |      | 170  |      |       | f = 1.0MHz, See Fig.5                                |
| C <sub>oss</sub> eff. (ER) | Effective Output Capacitance (Energy Related) ©             |      | 420  |      |       | $V_{GS} = 0V$ , $V_{DS} = 0V$ to $80V$ ©, See Fig.11 |
| C <sub>oss</sub> eff. (TR) | Effective Output Capacitance (Time Related)®                |      | 690  |      |       | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $          |

### **Diode Characteristics**

| Symbol           | Parameter                 | Min.    | Тур.     | Max.    | Units  | Conditions   |
|------------------|---------------------------|---------|----------|---------|--------|--|
| I <sub>S</sub>   | Continuous Source Current |         |          | 97      | Α      | MOSFET symbol  |
|                  | (Body Diode)              |         |          |         |        | showing the  |
| I <sub>SM</sub>  | Pulsed Source Current     |         |          | 390     | Α      | integral reverse   |
|                  | (Body Diode) ①            |         |          |         |        | p-n junction diode.                                      |
| $V_{SD}$         | Diode Forward Voltage     |         |          | 1.3     | V      | $T_J = 25^{\circ}C, I_S = 58A, V_{GS} = 0V \oplus$       |
| t <sub>rr</sub>  | Reverse Recovery Time     |         | 38       | 57      | ns     | $T_J = 25^{\circ}C$ $V_R = 85V$ ,                        |
|                  |                           |         | 46       | 69      | Ĭ      | $T_{\rm J} = 125^{\circ}{\rm C}$ $I_{\rm F} = 58{\rm A}$ |
| Q <sub>rr</sub>  | Reverse Recovery Charge   |         | 53       | 80      | nC     | $T_J = 25^{\circ}C$ di/dt = 100A/µs ④                    |
|                  |                           |         | 82       | 120     |        | $T_J = 125$ °C   |
| I <sub>RRM</sub> | Reverse Recovery Current  |         | 2.5      |         | Α      | $T_J = 25^{\circ}C$                                      |
| t <sub>on</sub>  | Forward Turn-On Time      | Intrins | ic turn- | on time | is neg | ligible (turn-on is dominated by LS+LD)                  |

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.143mH  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 58A,  $V_{GS}$  =10V. Part not recommended for use above this value.
- $\label{eq:local_spin_spin} \mbox{$\Im$} \ \ I_{SD} \leq 58A, \ di/dt \leq 610A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width  $\leq$  400 $\mu$ s; duty cycle  $\leq$  2%.

- $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \$   $\$   $\ \$   $\ \$   $\$
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

2 www.irf.com

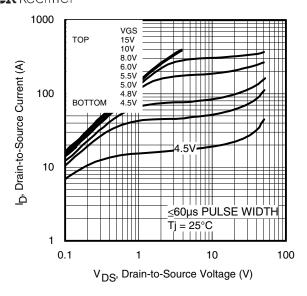


Fig 1. Typical Output Characteristics

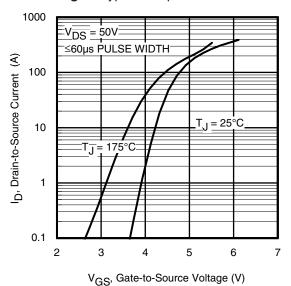
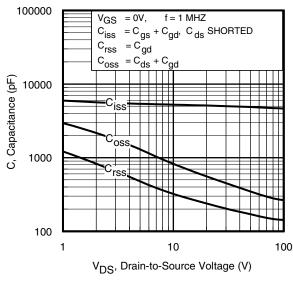


Fig 3. Typical Transfer Characteristics



**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage www.irf.com

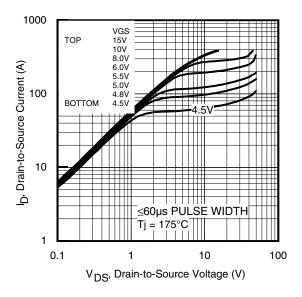


Fig 2. Typical Output Characteristics

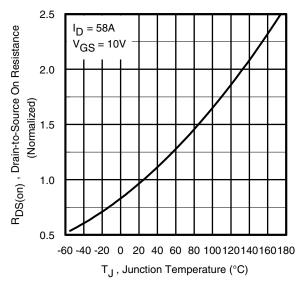


Fig 4. Normalized On-Resistance vs. Temperature

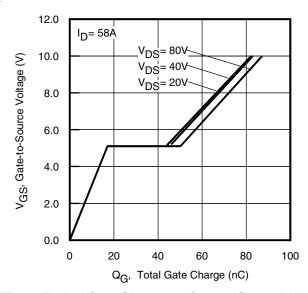
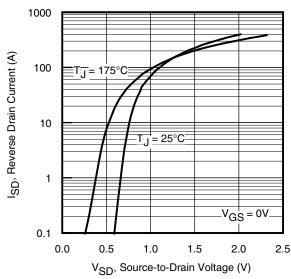
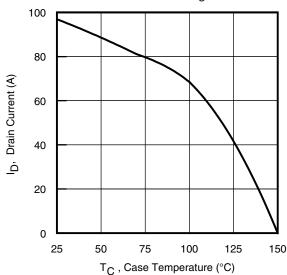


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 9.** Maximum Drain Current vs. Case Temperature

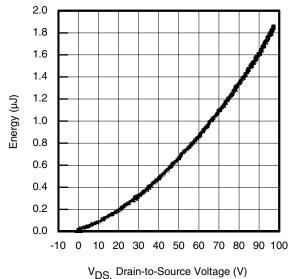


Fig 11. Typical C<sub>OSS</sub> Stored Energy

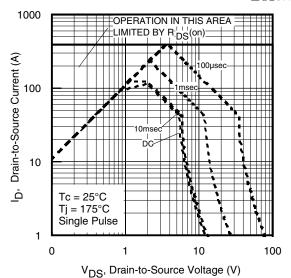


Fig 8. Maximum Safe Operating Area

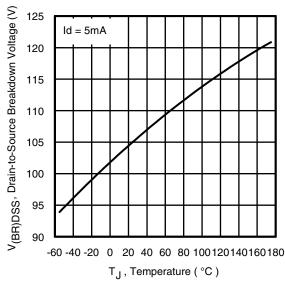


Fig 10. Drain-to-Source Breakdown Voltage

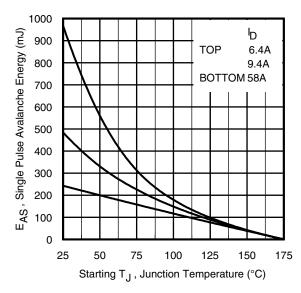


Fig 12. Maximum Avalanche Energy vs. DrainCurrent www.irf.com

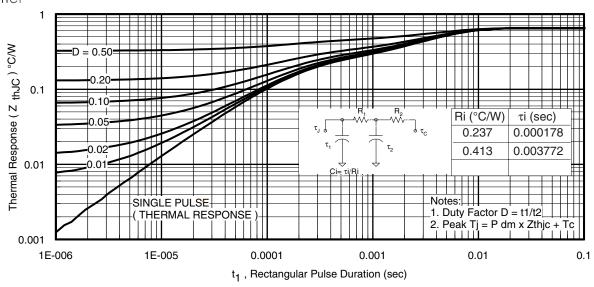


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

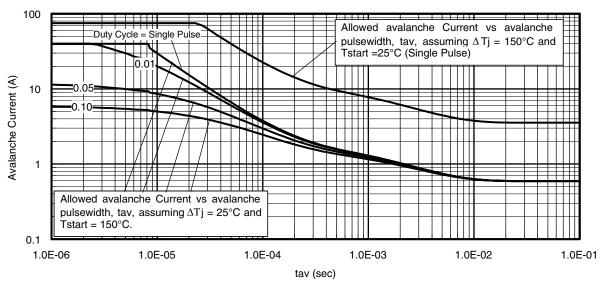


Fig 14. Typical Avalanche Current vs. Pulsewidth

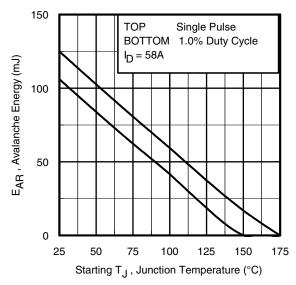


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4.  $P_{D (ave)}$  = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

t<sub>av</sub> = Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

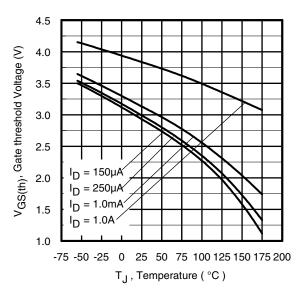


Fig 16. Threshold Voltage vs. Temperature

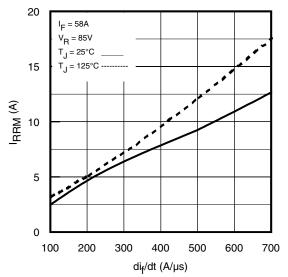


Fig. 18 - Typical Recovery Current vs. dif/dt

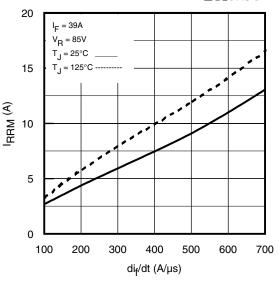


Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

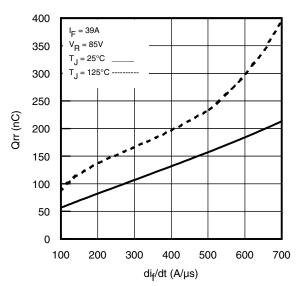


Fig. 19 - Typical Stored Charge vs. dif/dt

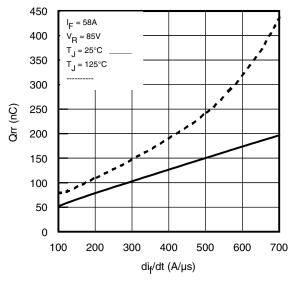


Fig. 20 - Typical Stored Charge vs. dif/dt

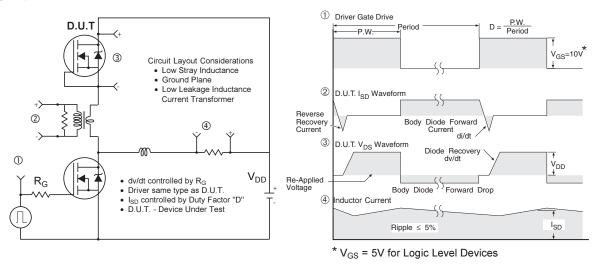


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

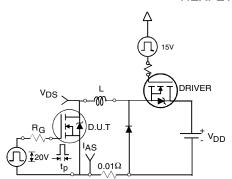


Fig 22a. Unclamped Inductive Test Circuit

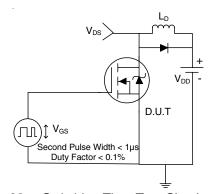
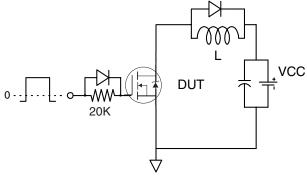


Fig 23a. Switching Time Test Circuit



**Fig 24a.** Gate Charge Test Circuit www.irf.com

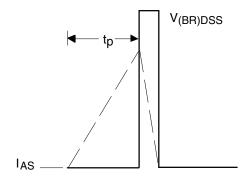


Fig 22b. Unclamped Inductive Waveforms

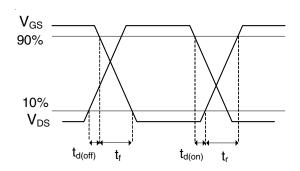


Fig 23b. Switching Time Waveforms

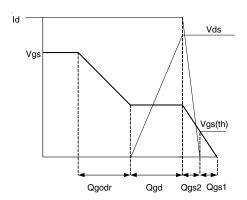


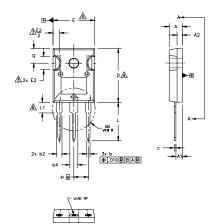
Fig 24b. Gate Charge Waveform

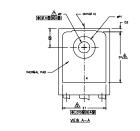
### IRFP4410ZPbF

## TO-247AC Package Outline

Dimensions are shown in millimeters (inches)











#### NOTES:

DIMENSIONING AND TOLERANCING AS PER ASME Y14,5M 1994.

DIMENSIONS ARE SHOWN IN INCHES.

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

 $\ensuremath{\mathrm{OP}}$  TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5  $^{\circ}$  TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC

|        | DIMENSIONS   |      |        |       |       |  |
|--------|--------------|------|--------|-------|-------|--|
| SYMBOL | INC          | HES  | MILLIM | ETERS | 1     |  |
|        | MIN.         | MAX. | MIN.   | MAX.  | NOTES |  |
| A      | .183         | .209 | 4.65   | 5.31  |       |  |
| A1     | .087         | .102 | 2.21   | 2.59  |       |  |
| A2     | .059         | .098 | 1.50   | 2.49  |       |  |
| ь      | .039         | .055 | 0.99   | 1.40  |       |  |
| ь1     | .039         | .053 | 0.99   | 1.35  |       |  |
| b2     | .065         | .094 | 1.65   | 2.39  |       |  |
| b3     | .065         | .092 | 1.65   | 2.34  |       |  |
| b4     | .102         | .135 | 2.59   | 3.43  |       |  |
| b5     | .102         | .133 | 2.59   | 3.38  |       |  |
| С      | .015         | .035 | 0.38   | 0.89  |       |  |
| c1     | .015         | .033 | 0.38   | 0.84  |       |  |
| D      | .776         | .815 | 19.71  | 20.70 | 4     |  |
| D1     | .515         | -    | 13.08  | -     | 5     |  |
| D2     | .020         | .053 | 0.51   | 1.35  |       |  |
| E      | .602         | .625 | 15.29  | 15.87 | 4     |  |
| E1     | .530         | -    | 13.46  | -     |       |  |
| E2     | .178         | .216 | 4.52   | 5.49  |       |  |
| е      | .215         | BSC  | 5.46   | BSC   | 1     |  |
| øk     | .010         |      | 0.     | 0.25  |       |  |
| L      | .559         | .634 | 14.20  | 16.10 | 1     |  |
| L1     | .146         | .169 | 3,71   | 4.29  |       |  |
| øΡ     | øP .140 .144 |      | 3.56   | 3.66  | 1     |  |
| øP1    | -            | .291 | -      | 7.39  |       |  |
| Q      | .209         | .224 | 5.31   | 5.69  |       |  |
| S      | .217         | BSC  | 5.51   |       |       |  |
|        |              |      |        |       |       |  |

#### LEAD ASSIGNMENTS

International

IOR Rectifier

# <u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE

#### IGBTs, CoPACK

2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

#### DIODES

1.- ANODE/OPEN 2.- CATHODE

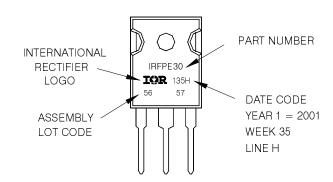
## TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30

WITH ASSEMBLY LOT CODE 5657

ASSEMBLED ON WW 35, 2001 IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position indicates "Lead-Free"



TO-247AC packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>

Data and specifications subject to change without notice. This product has been designed and qualified for the Industrial market. Qualification Standards can be found on IR's Web site.



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